


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/755,716	HAKOBYAN ET AL.	
	Examiner	Art Unit	
	Nam Huynh	2617	

SEARCHED			
Class	Subclass	Date	Examiner
455	410 411	11/23/2007	NTH
	61		
	435.1		
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	456.6		
370	313	11/23/2007	NTH
	326		
	330		
	335 336		
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
See EAST search notes.	11/23/2007	NTH